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# FDV302P Digital FET, P-Channel

#### **General Description**

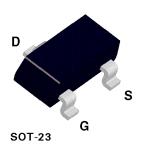
This P-Channel logic level enhancement mode field effect transistor is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. This device has been designed especially for low voltage applications as a replacement for digital transistors. Since bias resistors are not required, this one P-channel FET can replace several digital transistors with different bias resistors such as the DTCx and DCDx series.

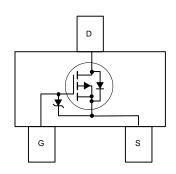
#### **Features**

- Very low level gate drive requirements allowing direct operation in 3V circuits. V<sub>GS(th)</sub> < 1.5V.</li>
- Gate-Source Zener for ESD ruggedness. >6kV Human Body Model
- Compact industry standard SOT-23 surface mount package.
- Replace many PNP digital transistors (DTCx and DCDx) with one DMOS FET.



Mark:302





#### **Absolute Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	FDV302P	Units
V <sub>DSS</sub>	Drain-Source Voltage	-25	V
$V_{GSS}$	Gate-Source Voltage	-8	V
I <sub>D</sub>	Drain Current - Continuous	-0.12	А
	- Pulsed	-0.5	
$P_{D}$	Maximum Power Dissipation	0.35	W
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	°C
ESD	Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf / 1500 Ohm)	6.0	kV
THERMA	L CHARACTERISTICS		•
R <sub>eJA</sub>	Thermal Resistance, Junction-to-Ambient	357	°C/W

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-25			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25 °C		-20		mV /°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -20 \text{ V}, \ V_{GS} = 0 \text{ V}$			-1	μA
		T <sub>J</sub> = 55°C			-10	μA
I <sub>GSS</sub>	Gate - Body Leakage Current	$V_{GS} = -8 \text{ V}, \ V_{DS} = 0 \text{ V}$			-100	nA
	CTERISTICS (Note)		•			
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25 °C		1.9		mV /°C
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.65	-1	-1.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -2.7 \text{ V}, I_D = -0.05 \text{ A}$		10.6	13	Ω
		$V_{GS} = -4.5 \text{ V}, I_D = -0.2 \text{ A}$		7.9	10	1
		T <sub>J</sub> =125°C		12	18	1
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -2.7 \text{ V}, \ V_{DS} = -5 \text{ V}$	-0.05			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -0.2 \text{ A}$		0.135		S
DYNAMIC C	HARACTERISTICS	•	•			
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V}, \ V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		11		pF
C <sub>oss</sub>	Output Capacitance			7		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			1.4		pF
SWITCHING	CHARACTERISTICS (Note)					
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DD} = -6 \text{ V}, \ I_{D} = -0.2 \text{ A},$ $V_{GS} = -4.5 \text{ V}, \ R_{GEN} = 50 \Omega$		5	12	ns
t <sub>r</sub>	Turn - On Rise Time			8	16	ns
$\mathbf{t}_{D(off)}$	Turn - Off Delay Time			9	18	ns
t,	Turn - Off Fall Time			5	10	ns
$Q_g$	Total Gate Charge	$V_{DS} = -5 \text{ V}, I_{D} = -0.2 \text{ A},$ $V_{GS} = -4.5 \text{ V}$		0.22	0.31	nC
$Q_{gs}$	Gate-Source Charge			0.11		nC
$Q_{gd}$	Gate-Drain Charge			0.04		nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MAX	KIMUM RATINGS		•	1	
I <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current				-0.2	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -0.2 \text{ A} \text{ (Note)}$		-1	-1.5	V

Note: Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2.0%.

### **Typical Electrical Characteristics**

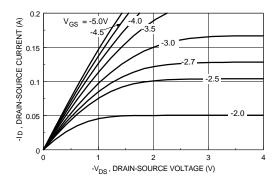


Figure 1. On-Region Characteristics.

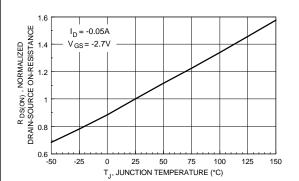


Figure 3. On-Resistance Variation with Temperature.

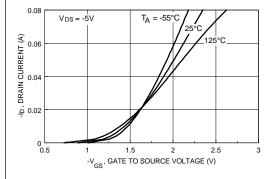


Figure 5. Transfer Characteristics.

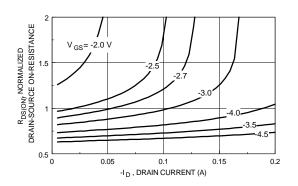


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

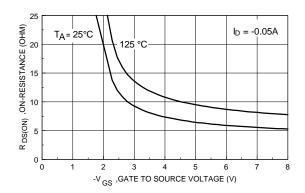


Figure 4. On Resistance Variation with Gate-To- Source Voltage.

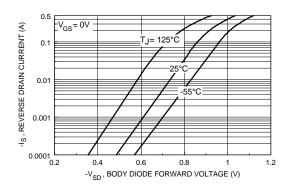


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Electrical And Thermal Characteristics**

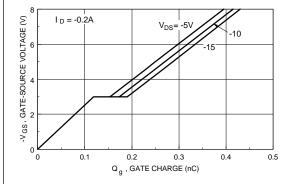


Figure 7. Gate Charge Characteristics.

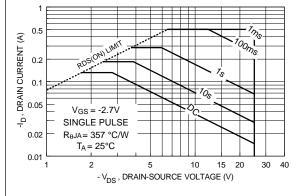


Figure 9. Maximum Safe Operating Area.

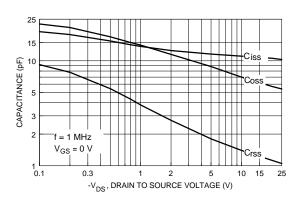


Figure 8. Capacitance Characteristics.

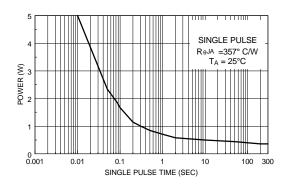


Figure 10. Single Pulse Maximum Power Dissipation.

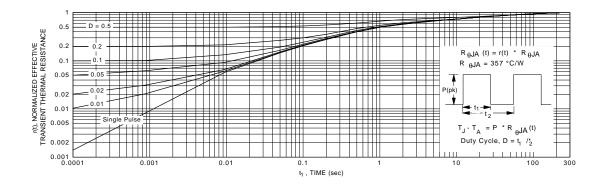


Figure 11. Transient Thermal Response Curve.

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